

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/088,719	FUJII ET AL.	
Examiner	Art Unit	
Amanda F. Wieker	3743	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated	11/9/2005	AFW		
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